Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination OHBA ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,432,831	07-1995	Nagai et al.	378/44
	В	US-		1 A .	
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	D	US-	·	:	
	E	US-			
	F	US-			
	G	US-		·	
	Н	US-			,
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	J	US-			•
	κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP6347600	12-1994	JAPAN	NAKAYAMA	G21K7/00
	0	·				
	Р					
	Q					
	R					
	s				·	
	Т				•	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	υ	R. C. Chase and J. K. Silk, "Ellipsoid-hyperboloid x-ray imaging instrument for laser-pellet diagnostics," Applied Optics 14, 2096 2098 (1975).						
	٧							
	w							
	×							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.